



UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Trademark Office
Address: COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450
www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/604,277	07/08/2003	Thomas R. Bednar	BUR920020092US1	1276
30449	7590	02/14/2006	EXAMINER	
SCHMEISER, OLSEN + WATTS			TAT, BINH C	
3 LEAR JET LANE				
SUITE 201			ART UNIT	
LATHAM, NY 12110			2825	
			PAPER NUMBER	

DATE MAILED: 02/14/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

H.A

Office Action Summary

Application No.

10/604,277

Applicant(s)

BEDNAR ET AL.

Examiner

Binh C. Tat

Art Unit

2825

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 21 November 2005.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 21-42 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 21-42 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 08 July 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____.
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____.

DETAILED ACTION

1. This office action is in response to application 10/604277 filed on 07/08/03.

Claims 21-42 remain pending in the application.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

3. Claims 21-42 are rejected under 35 U.S.C. 102(e) as being anticipated by Mizuno et al. (U.S Patent 6711071).

4. As to claims 21, and 31, Mizuno et al. disclose an electrical structure comprising: a parent terrain denoted as V0 (see fig 1, fig 2, fig 19-20, fig 27-28 and fig 29 element VDDQ col. 4 lines 45-63); and N voltage islands denoted as V1 (see fig 2, fig 19-20, fig 27-29 element PWR1, and GEN1 col. 5 lines 45 to col 6 lines 34; and col. 15 line 50 to col. 17 lines 45), and V2 said voltage island V1 nested within said parent terrain V0 and said voltage island V2 (see fig 24-26, fig 19-20, fig 27-29 element VLM1 and REG1; and col. 15 line 50 to col. 17 lines 45) nested within said voltage island (see fig 24-26, fig 19-20, fig 27-29 element VLM1 and REG1; and col. 15 line 50 to col. 17 lines 45).

5. As to claims 22, and 32, Mizuno et al. disclose wherein each voltage island of the N voltage island includes one or more voltage power supplies selected from the group consisting of

Art Unit: 2825

an internal voltage island VDDI power supply, an externally supplied state saving VDDSS power supply, an externally supplied VDDN power supply, and combinations thereof (see fig 1, fig 2, fig 19-20, fig 27-28 and fig 29 element VDDQ , VDD col. 4 lines 45 to col 5 line 44).

6. As to claims 23, and 33, Mizuno et al. disclose wherein said one or more power supplies of voltage island V_x for X_r--z_l , 2,..., N are each independently coupled to one of (a) said one or more power supplies of voltage island V_v for $Y=1, 2,..., N$, X not equal to Y , (b) a VDDO power supply of said parent terrain or (c) one or more external to said parent terrain power supplies (see fig 2, fig 19-20, fig 27-29 element PWR1, and GEN1 col. 5 lines 45 to col 6 lines 34; and col. 15 line 50 to col. 17 lines 45).

7. As to claims 24, and 34, Mizuno et al. disclose wherein each voltage island of the N voltage islands includes (a) an externally supplied VDDN power supply and a voltage shifting means, or (b) said externally supplied VDDN power supply and a fencing means or (c) said externally supplied VDDN power supply, said voltage shifting means and said fencing means (see fig 1, fig 2, fig 19-20, fig 27-28 and fig 29 element VDDQ , VDD col. 4 lines 45 to col 5 line 44 and abstraction).

8. As to claims 25, and 35, Mizuno et al. disclose wherein said fencing means comprises logic latches (see fig 1, fig 2, fig 19-20, fig 27-28 and fig 29 element VDDQ , VDD col. 4 lines 45 to col 5 line 44 and background).

9. As to claims 26, and 36, Mizuno et al. disclose wherein each voltage island of the N voltage islands further includes one or more substructures selected from the group consisting of (a) an internal voltage island VDDI power distribution network, (b) state saving means, (c) one or more switching elements coupled between said externally supplied VDDN power supply and

Art Unit: 2825

said internal voltage island VDDI power distribution network, and (d) one or more voltage buffering circuit (see fig 2, fig 19-20, fig 27-29 element PWR1, and GEN1 col. 5 lines 45 to col 6 lines 34; and col. 15 line 50 to col. 17 lines 45).

10. As to claims 27, and 37, Mizuno et al. disclose wherein said one or more switching elements is selected from the group consisting of hard connections, voltage regulators headers and footers (see fig 2, fig 19-20, fig 27-29 element PWR1, and GEN1 col. 5 lines 45 to col 6 lines 34; and col. 15 line 50 to col. 17 lines 45).

11. As to claims 28, and 38, Mizuno et al. disclose wherein said state saving means includes at least one state saving latch (see fig 2, fig 19-20, fig 27-29 element PWR1, and GEN1 col. 5 lines 45 to col 6 lines 34; and col. 15 line 50 to col. 17 lines 45).

12. As to claims 29, and 39, Mizuno et al. disclose wherein one or more voltage islands of the N voltage islands further includes a power management state machine coupled to an internal voltage island VDDI power supply distribution network, said power management state machine of voltage island V_x for $X=1, 2, \dots, N$ located in (a) voltage island V_y for $Y=1, 2, \dots, N$, Y less than X , or (b) in said parent terrain (see fig 2, fig 19-20, fig 27-29 element PWR1, and GEN1 col. 5 lines 45 to col 6 lines 34; and col. 15 line 50 to col. 17 lines 45 and abstraction).

13. As to claims 30, and 40, Mizuno et al. disclose wherein said parent terrain is an integrated circuit chip or a voltage island within said integrated circuit chip (see fig 1, fig 2, fig 19-20, fig 27-28 and fig 29 element VDDQ, VDD col. 4 lines 45 to col 5 line 44)..

14. As to claims 41, and 42 Mizuno et al. disclose further including: additional voltage islands denoted as V_3, V_4, \dots, V_n , a voltage island V_z nested within a voltage island V_{z-1} for

Art Unit: 2825

$Z = 3, 4, \dots, N$, wherein N is an integer of at least 3 (see fig 27-29 col 17 line 1 to col 18 lines 36).

Claim Rejections - 35 USC § 102

15. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

16. Claims 21-42 are rejected under 35 U.S.C. 102(e) as being anticipated by Bednar et al. (IEEE Managing Power and Performance for System-on-Chip Designs using Voltage Islands 2002).

17. As to claims 21, and 31, Mizuno et al. disclose an electrical structure comprising: a parent terrain denoted as V_0 (see fig 4 element V_c ; and fig 5 element VDD_0 power structure); and N voltage islands denoted as V_1 (see fig 4, element V_1 , and fig 5 element voltage island and description of the fig4, and fig 5), and V_2 said voltage island V_1 nested within said parent terrain V_0 and said voltage island V_2 (see fig 4, element V_{11} , and fig 5 and description of the fig4, and fig 5) nested within said voltage island (see fig 4, element V_{11} , and fig 5 and description of the fig4, and fig 5).

18. As to claims 22, and 32, Mizuno et al. disclose wherein each voltage island of the N voltage island includes one or more voltage power supplies selected from the group consisting of an internal voltage island VDD_I power supply, an externally supplied state saving VDD_{SS}

Art Unit: 2825

power supply, an externally supplied VDDN power supply, and combinations thereof (see fig 4, and fig 5 and description of the fig4, and fig 5).

19. As to claims 23, and 33, Mizuno et al. disclose wherein said one or more power supplies of voltage island V_x for $X=1, 2, \dots, N$ are each independently coupled to one of (a) said one or more power supplies of voltage island V_y for $Y=1, 2, \dots, N$, X not equal to Y , (b) a VDDO power supply of said parent terrain or (c) one or more external to said parent terrain power supplies (see fig 4, element V1, V2, V11, and V22 and description of the fig4) .

20. As to claims 24, and 34, Mizuno et al. disclose wherein each voltage island of the N voltage islands includes (a) an externally supplied VDDN power supply and a voltage shifting means, or (b) said externally supplied VDDN power supply and a fencing means or (c) said externally supplied VDDN power supply, said voltage shifting means and said fencing means (see fig 5 and description of the fig).

21. As to claims 25, and 35, Mizuno et al. disclose wherein said fencing means comprises logic latches (see fig 5 element Standard logic in island and description fig 5).

22. As to claims 26, and 36, Mizuno et al. disclose wherein each voltage island of the N voltage islands further includes one or more substructures selected from the group consisting of (a) an internal voltage island VDDI power distribution network, (b) state saving means, (c) one or more switching elements coupled between said externally supplied VDDN power supply and said internal voltage island VDDI power distribution network, and (d) one or more voltage buffering circuit (see fig 5 and description of the fig).

Art Unit: 2825

23. As to claims 27, and 37, Mizuno et al. disclose wherein said one or more switching elements is selected from the group consisting of hard connections, voltage regulators headers and footers (see fig 5 and description of the fig).

24. As to claims 28, and 38, Mizuno et al. disclose wherein said state saving means includes at least one state saving latch (see fig 5 element Standard logic in island and description fig 5).

25. As to claims 29, and 39, Mizuno et al. disclose wherein one or more voltage islands of the N voltage islands further includes a power management state machine coupled to an internal voltage island VDDI power supply distribution network, said power management state machine of voltage island V_x for $X=1, 2, \dots, N$ located in (a) voltage island V_y for $Y=1, 2, \dots, N$, Y less than X , or (b) in said parent terrain (see fig 4, element V1, V2, V11, and V22 and description of the fig4).

26. As to claims 30, and 40, Mizuno et al. disclose wherein said parent terrain is an integrated circuit chip or a voltage island within said integrated circuit chip.

As to claims 41, and 42 Mizuno et al. disclose further including: additional voltage islands denoted as V_3, V_4, \dots, V_n , a voltage island V_z nested within a voltage island V_{z-1} for $Z = 3, 4, \dots, N$, wherein N is an integer of at least 3 (see fig 4, element V1, V2, V11, and V22 and description of the fig4).

Art Unit: 2825

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Binh C. Tat whose telephone number is 571 272-1907. The examiner can normally be reached on 7:30 - 4:00 (M-F).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jack Chiang can be reached on 571 272-7483. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

BINH TAT
Art Unit 2825
February 2, 2005

Paul Dinh
PAUL DINH
PRIMARY EXAMINER